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Effects of Bi₂Mo₂O₉ addition on the sintering characteristics and microwave dielectric properties of BiSbO₄ ceramics

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Abstract

In this study, densification, microstructural evolution and microwave dielectric properties of $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ ceramics (x = 0 - 0.25) were investigated. Bi₂Mo₂O₉ was selected as the sintering aid as well as the modifier of the dielectric properties for BiSbO₄ ceramic. In comparison with pure BiSbO₄ densified at 1100 °C, the 0.75BiSbO₄-0.25Bi₂Mo₂O₉ composites emerged to reach maximum sintering density at 775 °C. No other second phase was detected while the microstructure exhibited a bimodal grain size distribution as both 1–2 µm large grains of Bi₂Mo₂O₉ and 0.2–0.5 µm fine grains of BiSbO₄ were observed. The ceramic with the best performance in terms of microwave dielectric properties in this system is found to be the 0.82BiSbO₄-0.18Bi₂Mo₂O₉ composite, which reports a ε_r of 24.3, a $Q \times f$ of 24,019 GHz, and a τ_f of -4 ppm/°C when sintered at 825 °C.

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1. Introduction

A high dielectric constant, high dielectric loss quality (Q > 2000), and near zero temperature coefficient of resonant frequency τ_f are required for applications in microwave devices, such as cellular phones, global positioning systems and personal communication systems. A high dielectric constant makes it possible to reduce the size of the material by a factor of $1/\varepsilon_r^{1/2}$ to facilitate considerable reduction in circuit size. A high Q value, on the other hand, enables low insertion loss and low bandwidth of the resonance frequency, both essential for achieving high frequency selectivity and stability in microwave transmitter components. A near-zero τ_f is further required for stabilizing frequency against temperature.

The sintering temperatures of common microwave dielectric ceramics fall in the range of 1200-1500 °C. The sintering temperatures of $Ba_2Ti_9O_{20}$, $Ba_{6-x}Ln_{8+2x/3}Ti_{18}O_{54}$, and (Zr,Sn)TiO₄ systems, for instance, are respectively 1300 °C, 1350 °C and 1400 °C, $^{1-3}$ all much higher than the melting

temperature of Ag (961 °C) or Cu (1064 °C). Several methods have been developed in response to the growing interest in new materials with a low sintering temperature. One method involves the investigation of glass-forming additives on the properties of established microwave materials.⁴ Another way is the use of new material systems with a lower sintering temperature.^{5,6} Recently, researchers have shown that bismuth-based ceramics, including the binary systems of Bi₂O₃–(Nb,Ta)₂O₅ and Bi₂O₃–(Sb,Ta)₂O₅,^{7–9} the ternary systems of Bi₂O₃–CaO–Nb₂O₅ and Bi₂O₃–ZnO–(Nb,Ta)₂O₅,^{7,10,11} possess low sintering temperatures ranging from 900 to 1100 °C and excellent microwave dielectric characteristics.

Examining the microwave dielectric properties of BiSbO₄ ceramic, the study of Wang and colleagues¹² reported a dielectric constant (ε_r) of 19, a $Q \times f$ value of 70,000 GHz, and a temperature coefficient of resonant frequency (τ_f) of $-62 \text{ ppm/}^{\circ}\text{C}$ at a sintering temperature of 1080 °C. Additives of the V₂O₅–CuO and B₂O₃–CuO systems were added to further lower the sintering temperature of BiSbO₄ ceramic.^{13,14} BiSbO₄ ceramic sintered with 1 wt% of V₂O₅–CuO and 0.6 wt% of B₂O₃–CuO at 930 °C demonstrated respectively the following microwave dielectric properties: $\varepsilon_r \approx 19$, $Q \times f \approx 40,000$ GHz, and $\tau_f \approx -71.5$ ppm/°C, and $\varepsilon_r \approx 19.47$, $Q \times f \approx 45,405$ GHz, and $\tau_f \approx -66.2$ ppm/°C.

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Instead of adding sintering additives, the study explores the different approach of introducing the low-sintering-temperature microwave dielectric ceramic Bi₂Mo₂O₉ not only to lower the sintering temperature but also to improve the microwave dielectric properties of BiSbO₄ ceramic. It was recently reported that Bi₂Mo₂O₉ ceramic could be sintered at 620 °C while still sustaining good microwave dielectric properties of $\varepsilon_r \approx 38$, $Q \times f \approx 12,500$ GHz, and $\tau_f \approx \pm 31$ ppm/°C.¹⁵ The effects of Bi₂Mo₂O₉ addition on the sintering characteristics and microwave dielectric properties of X-ray diffraction (XRD), scanning electron microscopy (SEM), thermal analysis, and dielectric characterization.

2. Experimental procedure

BiSbO₄ and Bi₂Mo₂O₉ in various ratios (ranging from 0 m% to 25 m%) were prepared using the solid-state reaction technique. Highly pure (>99.9% purity) Bi₂O₃ (Acros, Reagent grade), Sb₂O₃ (STREM, Reagent grade), and Mo₂O₃ (Alfa, Reagent grade) were used as raw materials. Oxides based on the constituents calculated from the ratio of BiSbO4 and Bi₂Mo₂O₉ were mixed and milled in methyl alcohol solution using polyethylene jars and zirconia balls for 24 h and then oven-dried at 80 °C for overnight. After drying, the powders were calcined at 850 °C for 4 h at a heating rate of 5 °C/min, and then re-milled in methyl alcohol for 24 h. The powders were added with 5 wt% of 15%-PVA solution and pressed into discshaped compacts under a uniaxial pressure of 140 MPa. The samples were then heat treated at 550 °C for 4 h to eliminate PVA, followed by sintering at 700-1200 °C for 2h (heating rate = $5 \circ C/min$), depending on the ceramic composition. Bulk densities of the sintered samples were measured using the Archimedes method with de-ionized water. Phase identification of the calcined powders as well as the sintered bulk ceramics was performed using X-ray diffraction (XRD, Simens D5000). Differential thermal and thermogravimetric analyses (DTA/TGA) were then conducted in a Pt crucible at a heating rate of 10 °C/min, using a Perkin-Elmer calorimeter (Series 1700 DTA), on the mixtures to evaluate the melting reactions. The samples used for SEM observation were thermally etched, and the microstructures were observed by scanning electron microscopy (SEM, JEOL 6500F) with an energy-dispersive spectroscopy (EDS). The densified cylindrical samples were polished to achieve an exact thickness of 5 mm for measuring microwave properties. The dielectric constants and unloaded Qvalues at microwave frequencies were measured in the $TE_{01\delta}$ mode using the Hakki and Colleman method¹⁶ and a network analyzer (HP 8722ES). Measurements of the temperature coefficient of the resonant frequency $\tau_{\rm f}$ in the temperature range of 25-85 °C were performed in a Delta Design box furnace. The $\tau_{\rm f}$ was defined by $(f_T - f_{25})/(f_{25}(T - 25 \,^{\circ}{\rm C}))$.

3. Results and discussion

Fig. 1 shows the apparent densities of the $(1-x)BiSbO_4-xBi_2Mo_2O_9$ composite ceramics sintered



Fig. 1. Sintered densities of $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ composite ceramics sintered at different temperatures for 2 h.

at different temperatures. Pure BiSbO₄ reached maximum densification at 1100 °C in 2 h, and a sintered density exceeding 95% theoretical density $(8.459 \text{ g/cm}^3)^{17}$ was achieved. Addition of Bi₂Mo₂O₉ triggered a significant drop in the densification temperature. The (1 - x)BiSbO₄-xBi₂Mo₂O₉ composite ceramics with x = 0.05 reached maximum densification at



Fig. 2. DTA/TGA curves of $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ composite ceramics sintered at different temperatures.



Fig. 3. XRD patterns of $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ composite ceramics sintered at different temperatures.

925 °C. As the x approached 0.25, maximum densification was achieved at 775 °C. The maximum theoretical density of the ceramics decreased with increasing Bi₂Mo₂O₉ content, ranging from 92% to 98%. It should be noted that no precalcination of BiSbO₄ and Bi₂Mo₂O₉ was performed before mixing the composite. The BiSbO₄-Bi₂Mo₂O₉ composites were prepared directly using the metal oxides. Proportional ratios of Bi₂O₃, Sb₂O₃, and Mo₂O₃ were mixed, calcined at 850 °C, re-milled, pelletized and then sintered. The study found that precalcination of the BiSbO₄ and Bi₂Mo₂O₉ compounds led to warped dimension after sintering. Common low-fire microwave ceramics often encounter a narrow processing window due to high vapor pressure at high temperatures, causing inhomogeneous composition and microstructural evolution and resulting in the inability to reproduce the microwave dielectric properties. It is worth noting that the sintered $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ ceramics appeared to have a homogeneous sintering shrinkage and a uniform color indicating homogeneity of the composition. There was no visible weight loss due to evaporation of various species during sintering.

It was found from the XRD and DTA/TGA results that the formation of Bi₂Mo₂O₉ and BiSbO₄ phases in the mixture of Bi₂O₃, Sb₂O₃, and Mo₂O₃ during calcination process was proceeded at the temperatures around 428 °C and 792 °C, fairly close to those reported in the literature.^{12,15} Fig. 2 shows the DTA/TGA curves of the calcined (1 - x)BiSbO₄-xBi₂Mo₂O₉ powders heated up to 1200 °C. For pure BiSbO₄, as indicated by Fig. 2(a), there is no reaction below the temperatures measured since the endothermic melting reaction occurred at the temperature of \approx 1276 °C.²⁰ Three small endothermic peaks emerged respectively at 676, 780 and 958 °C for the BiSbO₄ powders with various amounts of Bi₂Mo₂O₉, with the former two corresponding to the incongruent melting points of Bi₂Mo₂O₉¹⁸ and the last one to the irreversible phase transition temperature



Fig. 4. Raman spectra of $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ composite ceramics sintered at different temperatures.

of BiSbO₄. Fig. 2(b) presents the TGA results of the BiSbO₄ powders with various amounts of Bi₂Mo₂O₉. Significant weight loss was observed at temperatures higher than ≈ 1100 °C for pure BiSbO₄ and ≈ 1000 °C for 0.75BiSbO₄–0.25Bi₂Mo₂O₉.



Fig. 5. SEM micrographs of (a) BiSbO₄ ceramic sintered at 1100 °C for 2 h, and (b) 0.75BiSbO₄-0.25Bi₂Mo₂O₉ composites sintered at 775 °C for 2 h.



Fig. 6. Grain size distributions of the BiSbO₄ matrix for (a) BiSbO₄ ceramic sintered at $1100 \,^{\circ}$ C, (b) 0.95BiSbO₄-0.05Bi₂Mo₂O₉ ceramic sintered at 925 $^{\circ}$ C, (c) 0.82BiSbO₄-0.18Bi₂Mo₂O₉ ceramic sintered at 825 $^{\circ}$ C, and (d) 0.75BiSbO₄-0.25Bi₂Mo₂O₉ ceramic sintered at 775 $^{\circ}$ C.

A comparison of the data in Figs. 1 and 2(b) suggests that addition of $Bi_2Mo_2O_9$ not only reduces the sintering temperature of the $BiSbO_4$ ceramic but also pushes the maximum densification temperature away from the onset temperatures of the rapid weight loss due to evaporation.

illustrates the XRD Fig. 3 patterns of the $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ ceramics with various Bi_2Mo_2O_9 contents. The XRD patterns were identified as BiSbO₄ and Bi₂Mo₂O₉ phases. BiSbO₄ has a monoclinic structure [I2/c space group, a = 5.4690, b = 4.8847, c = 11.8252 Å, and $\beta = 101.131^{\circ}$].¹⁹ X-ray diffraction data show that Bi₂Mo₂O₉ has a monoclinic structure (P21/n), with lattice parameters a = 11.9664, b = 10.8089, c = 11.8871 Å, and $\beta = 90.13^{\circ}$.¹⁵ The intensities of the peaks corresponding to the BiSbO₄ and Bi₂Mo₂O₉ phases are consistent with their contents in the starting powders. No other second phase has been found in the XRD results, except the BiSbO₄ and Bi₂Mo₂O₉ phases. Fig. 4 shows the Raman spectra (wavelength of excitation 514 nm) of the $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ composite ceramics sintered at different temperatures. The Raman spectra located at 397, 454, 788, and 256 cm^{-1} corresponded to BiSbO₄ while the ones at 889, 757, 360, and $285 \,\mathrm{cm}^{-1}$ corresponded to Bi₂Mo₂O₉. Consistent with the XRD results shown in Fig. 3, the characteristic peaks of Bi₂Mo₂O₉ rose and that of BiSbO₄ declined with increased Bi₂Mo₂O₉ addition.

Typical SEM micrographs for the $(1-x)BiSbO_4-xBi_2Mo_2O_9$ ceramics, as shown in Fig. 5(a) and (b), corresponded respectively to the BiSbO₄ ceramic sintered at 1100 °C and the 0.75BiSbO₄-0.25Bi₂Mo₂O₉

composite sintered at 775 °C. The pure BiSbO₄ ceramic shows a microstructure composed of angular grains in the sizes of $0.2-1 \,\mu\text{m}$. With the addition of $Bi_2Mo_2O_9$ in the BiSbO₄ ceramic, the microstructure exhibited a bimodal grain size distribution as both $1-2 \,\mu m$ large grains and $0.2-0.5 \,\mu m$ fine grains were observed. EDS results confirmed that the large grains of area A and the fine grains of area B corresponded respectively to the Bi2Mo2O9 and BiSbO4 ceramics, all in agreement with the XRD and Raman results presented in Figs. 3 and 4. The Bi₂Mo₂O₉ addition reduced the sintering temperature of BiSbO₄ and thus inhibited the grain growth of BiSbO₄ matrix. The SEM microstructures also show no second phase along the grain boundaries, thus confirming the XRD results in Fig. 3. As indicated by Fig. 6 that shows the grain size distributions of the BiSbO₄ matrix for the BiSbO₄ ceramic (sintered at 1100 °C), the 0.95BiSbO₄-0.05Bi₂Mo₂O₉ ceramic (sintered at 925 °C), the 0.82BiSbO₄-0.18Bi₂Mo₂O₉ ceramic (sintered at 825 °C), and the 0.75BiSbO₄-0.25Bi₂Mo₂O₉ ceramic (at 775 °C), it is evident that the grain size distribution of the BiSbO4 matrix became narrower and shifted to the smaller grain size as the Bi₂Mo₂O₉ content increased. The average grain size of the BiSbO₄ matrix decreased from 0.45 to $0.12 \,\mu\text{m}$ as the Bi₂Mo₂O₉ content escalated from 0 to 25 m%. On the other hand, the grain size of the Bi₂Mo₂O₉ phase ranged from 0.5 to $2.5 \,\mu\text{m}$, showing no obvious variance along with its content in the composites. The shrinkage in the grain size of the BiSbO₄ matrix is mainly due to the significant reduction in the sintering temperature of the composites with the growth in the Bi₂Mo₂O₉ content.



Fig. 7. Dielectric constant, quality factors, and temperature coefficients of $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ composite ceramics with various x values.

Table 1 Microwave dielectric properties of BiSbO₄–Bi₂Mo₂O₉ composite ceramics with various x values.

Composition	<i>ɛ</i> r	$Q \times f(\text{GHz})$	$\tau_f (\text{ppm/}^\circ C)$
BiSbO ₄	19.8	71,291	-42
0.95BiSbO4-0.05Bi2Mo2O9	21.8	64,780	-47
0.92BiSbO ₄ -0.08Bi ₂ Mo ₂ O ₉	21.6	35,115	-28
0.89BiSbO ₄ -0.11Bi ₂ Mo ₂ O ₉	21.1	18,470	-10
0.82BiSbO4-0.18Bi2Mo2O9	24.3	24,019	-4
0.75BiSbO4-0.25Bi2Mo2O9	25.8	8,735	+4

The microwave dielectric properties, including dielectric constant (ε_r), quality factor ($Q \times f$), and temperature coefficient of resonant frequency (τ_f) , of the $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ ceramics with maximum densification are shown in Fig. 7 and summarized in Table 1. The dielectric constants of the $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ ceramics ranged from 19.8 to 25.8. The ceramic with x = 0 (BiSbO₄) reported the lowest dielectric constant of 19.8, as shown in Fig. 7. The dielectric constant of the $(1-x)BiSbO_4-xBi_2Mo_2O_9$ ceramics increased with the growth in Bi₂Mo₂O₉ content, since the Bi₂Mo₂O₉ registers a dielectric constant of 38.¹⁵ The $Q \times f$ values of the $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ ceramics experienced a drastic decline with increased Bi2Mo2O9 substitution, for example, from 71,291 for pure BiSbO₄ ceramics to 8735 for its $0.75BiSbO_4-0.25Bi_2Mo_2O_9$ counterpart. The τ_f value varied from -42 to +4 ppm/°C and grew less negative as the added amount of Bi₂Mo₂O₉ rose. The 0.82BiSbO₄-0.18Bi₂Mo₂O₉ ceramics emerged to be the ceramic with the best performance in terms of microwave dielectric properties (a ε_r of 24.3, a $Q \times f$ of 24,019 GHz, and a τ_f of -4 ppm/°C) when sintered at 825 °C.

4. Conclusion

Based on the study results, the densification, thermal properties, microstructural evolution and dielectric properties of the $(1 - x)BiSbO_4 - xBi_2Mo_2O_9$ composites (x = 0 - 0.25) are summarized as follows.

- BiSbO₄ reaches maximum densification at 1000 °C, and the 0.75BiSbO₄-0.25Bi₂Mo₂O₉ composites achieve maximum sintering density at 775 °C.
- In the XRD patterns and Raman spectra of the composites, BiSbO₄ and Bi₂Mo₂O₉ phases are identified while no other second phase has been found. With addition of Bi₂Mo₂O₉ in the BiSbO₄ ceramic, the microstructure exhibits a bimodal grain size distribution indicated by the presence of both 1–2 µm large grains and 0.2–0.5 µm fine grains.
- 3. The microwave dielectric properties of the pure BiSbO₄ sintered at 1100 °C can be summarized as $\varepsilon_{\rm r} \approx 19.8$, $Q \times f \approx 71,291$ GHz, and $\tau_{\rm f} \approx -42$ ppm/°C. The ceramic with the best performance in terms of microwave dielectric properties in this system goes to the 0.82BiSbO₄-0.18Bi₂Mo₂O₉ ceramic, which reports a $\varepsilon_{\rm r}$ of 24.3, a $Q \times f$ of 24,019 GHz, and a $\tau_{\rm f}$ of -4 ppm/°C when sintered at 825 °C.

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